## Notice of References Cited Application/Control No. 10/581,740 Applicant(s)/Patent Under Reexamination AUNET, SNORRE Examiner Anh Q. Tran Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,232,793	05-2001	Arimoto et al.	326/34
*	В	US-2005/0162212	07-2005	Sakiyama et al.	327/534
	O	US-			
	D	US-			
	E	US-			
	F	US-	,		
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
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## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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